

# SAW Components Data Sheet CQTSR433M42.00

| Customer's Approval Certificate                                       |       |  |  |  |  |  |
|---|-------|--|--|--|--|--|
| Complies with Directive 2002/95/EC (RoHS)                             |       |  |  |  |  |  |
| Please return this Page Via email as a certification of Your approval |       |  |  |  |  |  |
| Checked & Approval by:  | Date: |  |  |  |  |  |
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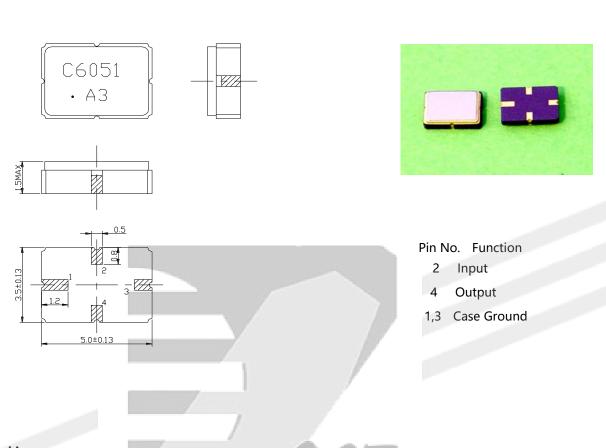
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# 1. Package Dimension

Unit: mm



# 2. Marking

| 1 |            |                |  |  |  |  |
|---|------------|----------------|--|--|--|--|
|   | C6051      | (1) Model code |  |  |  |  |
|   | CHINA QUAR | (2) Date code  |  |  |  |  |

| А          | 3                   |  |  |  |  |
|------------|---------------------|--|--|--|--|
| Month code | Last figure of year |  |  |  |  |

| Month      | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | 10 | 11 | 12 |
|------------|---|---|---|---|---|---|---|---|---|----|----|----|
| Month code | Α | В | С | D | E | F | G | Н | I | J  | K  | L  |

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### 3. Performance

## 3.1 Application

One-port SAW Resonator for Wireless Remote Controller.

Center frequency: 433.42MHz

### 3.2 Maximum Rating

| Rating                             | Value                   | Unit       |     |
|------------------------------------|-------------------------|------------|-----|
| Operating Temperature Range        | T <sub>A</sub>          | -40 ~ +85  | °C  |
| Storage Temperature Range          | $\mathcal{T}_{stg}$     | -45 ~ +125 | °C  |
| DC Voltage (between any Terminals) | $V_{DC}$                | 10         | V   |
| RF Power (in <i>BW</i> )           | Р                       | 10         | dBm |
| ESD Voltage (HB)                   | <b>V</b> <sub>ESD</sub> | 150        | V   |

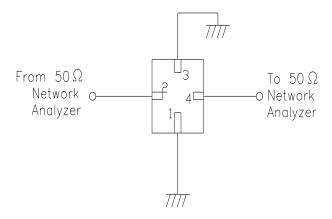
### Electrostatic Sensitive Device (ESD)

## 3.3 Electronic Characteristics

| Item                                    | Unit    | Minimum      | Typical | Maximum |
|---|---------|--------------|---------|---------|
| Center Frequency (fo)                   | MHz     | 433.345      | 433.42  | 433.495 |
| Insertion Loss                          | dB      | /_           | 1.3     | 2.0     |
| Quality Factor                          | -       | _            | _       | _       |
| Unloaded Q                              | - /     | _            | 11,000  | _       |
| 50Ω Loaded Q                            | D.      | AT.          | 2,000   | _       |
| Temperature Stability                   | W-11    | <i>]  </i> - | _       |         |
| Turnover Temperature                    | ℃       | 25           | 39      | 55      |
| Frequency Temperature Coefficient       | ppm/°C² | 01.007       | 0.032   | _       |
| Frequency Aging                         | ppm/yr  | OLOG 1       | <±10    |         |
| DC Insulation Resistance                | ΜΩ      | 1.0          | _       |         |
| RF Equivalent RLC Model                 | _       |              |         |         |
| Motional Resistance R <sub>1</sub>      | Ω       | _            | 18      | 26      |
| Motional Inductance L <sub>1</sub>      | μН      | _            | 86      | _       |
| Motional Capacitance C <sub>1</sub>     | fF      | _            | 1.56    | _       |
| Shunt Static Capacitance C <sub>0</sub> | pF      | 1.7          | 2.0     | 2.3     |

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### 3.4 Test Circuit



### 4 Reliability

- 4.1 Mechanical Shock: The components shall remain within the electrical specifications after three one-half sine shock pulses(3000g's for 0.3 ms) in each direction(for six total) along each of the three mutually perpendicular axes for a total of 18 shocks.
- 4.2 Vibration Fatigue: The components shall remain within the electrical specifications after loaded vibration at 20~55Hz, amplitude 1.5mm, X,Y,Z, direction, for 2 hours.
- 4.3 Leak Test
- 4.3.1 Gross Leak Test: Submerge samples into at +85°C water for at least 1 minute. Carefully observe the samples. No bubbles should be seen.
- 4.3.2 Fine Leak Test: Expose samples for testing to 60 PSIG Helium gas for 2 hours. Then transfer the same samples to another chamber and draw a vacuum. Measure the leak rate. Failure is defined if the leak rate exceeds  $5 \times 10^{-8}$  atm cc/sec Helium.
- 4.4 High Temperature Storage: The components shall remain within the electrical specifications after being kept at the 85°C±2°Cfor 960 hours, then kept at room temperature for 2 hours.
- 4.5 Low Temperature Storage: The components shall remain within the electrical specifications after being kept at the 40°C±2°Cfor 960 hours, then kept at room temperature for 2 hours.
- 4.6 Temperature Cycle: The components shall remain within the electrical specification after 32 cycles of high and low temperature testing (one cycle: 80°C for 30 minutes → 25°C for 20 seconds → -40°C for 30 minutes) than kept at room temperature for 2 hours.
- 4.7 Humidity Test: The components shall remain within the electrical specifications after being kept at the condition of ambient temperature 70°C, and 90~95% RH for 240 hours, then kept at room temperature and normal humidity for 4 hours.
- 4.8 Solder-heat Resistance: The components shall remain within the electrical specifications after dipped in the solder at 260°C±5°C for 10 to 11 seconds, then kept at room temperature for 10 minutes.
- 4.9 Solderability: Solderability of terminal shall be kept at more than 80% after dipped in the solder flux at  $230^{\circ}\text{C}\pm5^{\circ}\text{C}$  for  $5\pm1$  seconds.
- 4.10 Storage: The components shall meet the electrical and mechanical specifications after 5 years storage, if stored within the temperature range of -40°C~+85°C and in the humidity of 20 to 60% r.h.

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